

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10614738	MITRA ET AL.
	Examiner ALLAHYAR KASRAIAN	Art Unit 2617

SEARCHED

Class	Subclass	Date	Examiner
370	392	10/10/2007	AK
370	400	10/10/2007	AK
370	351	10/10/2007	AK
370	238	10/10/2007	AK
370	242	10/10/2007	AK
709	238, 244	12/1/2010	AK

SEARCH NOTES

Search Notes	Date	Examiner
EAST Image and keyword search in USPTO, US-PGPUB, DERWENT, EPO, JPO, and IBM_TDB (see attached seach strategy)	10/10/2007	AK
Inventor name and Assignee search in PALM ExPo and EAST	10/10/2007	AK
IEEE Xplore: http://ieeexplore.ieee.org/Xplore/DynWel.jsp	10/10/2007	AK
Google: http://www.google.com	10/10/2007	AK
EPO Data base: http://ep.espacenet.com	10/10/2007	AK
(370/392,351,352,400.ccls. 709/238,238,241,242.ccls.) and ((path link) near5 (determin\$5 estimat\$5)) and @ay<="2003"	10/10/2007	AK
Updated search	3/18/2008	AK
Updated search	9/12/2008	AK
Updated search	3/1/2009	AK
Updated search	11/13/2009	AK
Updated search	5/20/2010	AK
709/238-244.ccls. and (connect\$5 near2 request\$3) and (evaluat\$3 determin\$3 calculat\$5 examin\$5) with (path link edge) with ((source with destination) (engress ingress))	12/1/2010	AK
updated search	12/1/2010	AK
Constulated with Rafael Pérez-Gutiérrez	12/1/2010	AK
Constulated with Jinsong Hu	12/1/2010	AK

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

/A. K./
Examiner.Art Unit 2617